

SHEET 1 OF 1

INFORMATION DISCLOSURE
CITATION IN AN
APPLICATION

(PTO-1449)

ATTY. DOCKET NO.
065933-0065SERIAL NO.
10/754,926APPLICANT
Yukihiro NOGUCHI, et al.FILING DATE
January 12, 2004GROUP
2819

U.S. PATENT DOCUMENTS

EXAMINER'S INITIALS	CITE NO.	Document Number Number-Kind Codes (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		US			
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FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	CITE NO.	Foreign Patent Document Country Codes-Number + Kind Codes (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines Where Relevant Figures Appear	Translation Yes No
AT		JP 03-291013	12/20/1991	SUMITOMO ELECTRIC IND LTD.		JAPAN (w/English Abstract)

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER'S INITIALS	CITE NO.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.

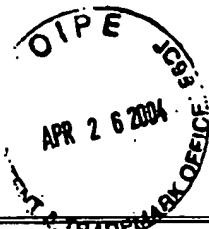
EXAMINER

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9/15/03

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1 Applicant's unique citation designation number (optional). 2 Applicant is to place a check mark here if English language Translation is attached.



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AT		US 5,387,828	02/07/1995	Nakano	
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						Yes	No

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

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				APPLICANT Yukihiro NOGUCHI, et al.			
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<div style="font-size: 1.5em; font-family: cursive;">AT</div>		US 6,344,764 B2	02/05/2002	Tanzawa			
		US 4,486,670	12/04/1984	Chan et al.			
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						Yes	No
<div style="font-size: 1.5em; font-family: cursive;">AT</div>		JP 6-177744 (w/ English Abstract) & EP 600734 A1, US 5,387,828 A	06/24/1994	NEC CORP.			
		JP 6-204850 (w/ English Abstract)	07/22/1994	OKI ELECTRIC IND. CO., LTD.			
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		JP 2000-286694 (w/ English Abstract) & 6,262,598 B1	10/13/2000	SHARP CORP.			
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		JP 1-176115 (w/ English Abstract)	07/12/1989	NEC CORP.			
		JP 9-205351 (w/ English Abstract) & 6,087,880	08/05/1997	SONY CORP.			
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		JP 1-253309		COPY NOT ENCLOSED.			
OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)							
EXAMINER'S INITIALS	CITE NO.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.					
		EXAMINER <div style="font-size: 1.5em; font-family: cursive;">[Signature]</div>			DATE CONSIDERED <div style="font-size: 1.5em; font-family: cursive;">9/15/05</div>		

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